



APSEMI

AC2M0045170D
Silicon Carbide Power MOSFET
N-Channel Enhancement Mode

Features

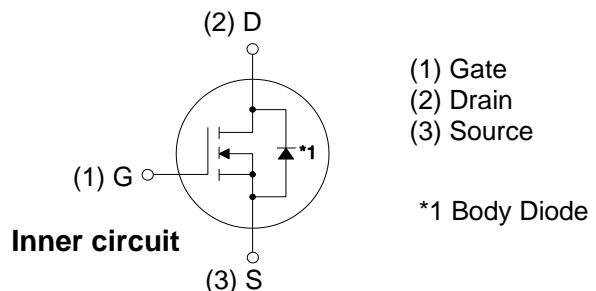
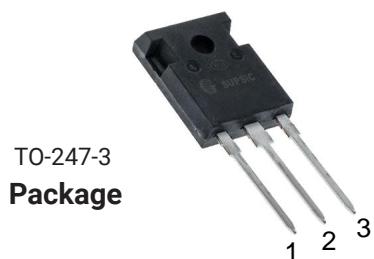
- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive
- 6) Pb-free lead plating ; RoHS compliant

Parameter	Rating	Units
V_{DS}	1700	V
I_D @ 25°C	74	A
$R_{DS(on)}$	45	m Ω



Applications

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- Induction heating



Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1700	V	$V_{GS} = 0 \text{ V}$, $I_D = 100 \mu\text{A}$	
V_{GSmax}	Gate - Source Voltage	-10/+25	V	Absolute maximum values, AC ($f > 1 \text{ Hz}$)	
V_{GSop}	Gate - Source Voltage	-5/+20	V	Recommended operational values	
I_D	Continuous Drain Current	74	A	$V_{GS} = 20 \text{ V}$, $T_c = 25^\circ\text{C}$	
		48		$V_{GS} = 20 \text{ V}$, $T_c = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	160	A	Pulse width t_p limited by T_{jmax}	
P_D	Power Dissipation	520	W	$T_c = 25^\circ\text{C}$, $T_j = 150^\circ\text{C}$	
T_j , T_{stg}	Operating Junction and Storage Temperature	-40 to +150	°C		
T_L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
M_d	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	



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Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	1700			V	$V_{\text{GS}} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	2.6	4	V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 18 \text{ mA}$	
			1.8		V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 18 \text{ mA}, T_J = 150^\circ\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current		2	100	μA	$V_{\text{DS}} = 1700 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	
I_{GSS}	Gate-Source Leakage Current			600	nA	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	
$R_{\text{DS}(\text{on})}$	Drain-Source On-State Resistance		45	70	$\text{m}\Omega$	$V_{\text{GS}} = 20 \text{ V}, I_D = 50 \text{ A}$	
			90			$V_{\text{GS}} = 20 \text{ V}, I_D = 50 \text{ A}, T_J = 150^\circ\text{C}$	
g_{fs}	Transconductance		21.7		S	$V_{\text{DS}} = 20 \text{ V}, I_{\text{DS}} = 50 \text{ A}$	
			24.4			$V_{\text{DS}} = 20 \text{ V}, I_{\text{DS}} = 50 \text{ A}, T_J = 150^\circ\text{C}$	
C_{iss}	Input Capacitance		3617		pF	$V_{\text{GS}} = 0 \text{ V}$	
C_{oss}	Output Capacitance		171			$V_{\text{DS}} = 1200 \text{ V}$	
C_{rss}	Reverse Transfer Capacitance		6.7			$f = 1 \text{ MHz}$	
E_{oss}	C_{oss} Stored Energy		105			$V_{\text{AC}} = 25 \text{ mV}$	
E_{ON}	Turn-On Switching Energy (SiC Diode FWD)		2.1		mJ	$V_{\text{DS}} = 1200 \text{ V}, V_{\text{GS}} = -5/20 \text{ V},$	
E_{OFF}	Turn Off Switching Energy (SiC Diode FWD)		0.86			$I_D = 50 \text{ A}, R_{\text{G(ext)}} = 2.5 \Omega, L = 105 \mu\text{H}, T_J = 150^\circ\text{C}$, using SiC Diode as FWD	
E_{ON}	Turn-On Switching Energy (Body Diode FWD)		4.7		mJ	$V_{\text{DS}} = 1200 \text{ V}, V_{\text{GS}} = -5/20 \text{ V},$	
E_{OFF}	Turn Off Switching Energy (Body Diode FWD)		0.93			$I_D = 50 \text{ A}, R_{\text{G(ext)}} = 2.5 \Omega, L = 105 \mu\text{H}, T_J = 150^\circ\text{C}$, using MOSFET as FWD	
$t_{\text{d(on)}}$	Turn-On Delay Time		65		ns	$V_{\text{DD}} = 1200 \text{ V}, V_{\text{GS}} = -5/20 \text{ V}$	
t_r	Rise Time		20			$I_D = 50 \text{ A}, R_{\text{G(ext)}} = 2.5 \Omega$, Timing relative to V_{DS}	
$t_{\text{d(off)}}$	Turn-Off Delay Time		48			Inductive load	
t_f	Fall Time		18				
$R_{\text{G(int)}}$	Internal Gate Resistance		1.3		Ω	$f = 1 \text{ MHz}, V_{\text{AC}} = 25 \text{ mV}$	
Q_{gs}	Gate to Source Charge		44		nC	$V_{\text{DS}} = 1200 \text{ V}, V_{\text{GS}} = -5/20 \text{ V}$	
Q_{gd}	Gate to Drain Charge		57			$I_D = 50 \text{ A}$	
Q_g	Total Gate Charge		186			Per IEC60747-8-4 pg 21	

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.1		V	$V_{\text{GS}} = -5 \text{ V}, I_{\text{SD}} = 25 \text{ A}$	
		3.6		V	$V_{\text{GS}} = -5 \text{ V}, I_{\text{SD}} = 25 \text{ A}, T_J = 150^\circ\text{C}$	
I_s	Continuous Diode Forward Current		72	A	$T_c = 25^\circ\text{C}, V_{\text{GS}} = -5 \text{ V}$	
t_{rr}	Reverse Recovery Time	70		ns	$V_{\text{GS}} = -5 \text{ V}, I_{\text{SD}} = 50 \text{ A}, V_R = 1200 \text{ V}$ $dI/dt = 1400 \text{ A}/\mu\text{s}$	
Q_{rr}	Reverse Recovery Charge	530		nC		
I_{rrm}	Peak Reverse Recovery Current	14		A		

Note (1): When using SiC Body Diode the maximum recommended $V_{\text{GS}} = -5 \text{ V}$

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\text{θJC}}$	Thermal Resistance from Junction to Case	0.22	0.24	$^\circ\text{C}/\text{W}$		
$R_{\text{θJC}}$	Thermal Resistance from Junction to Ambient		40			



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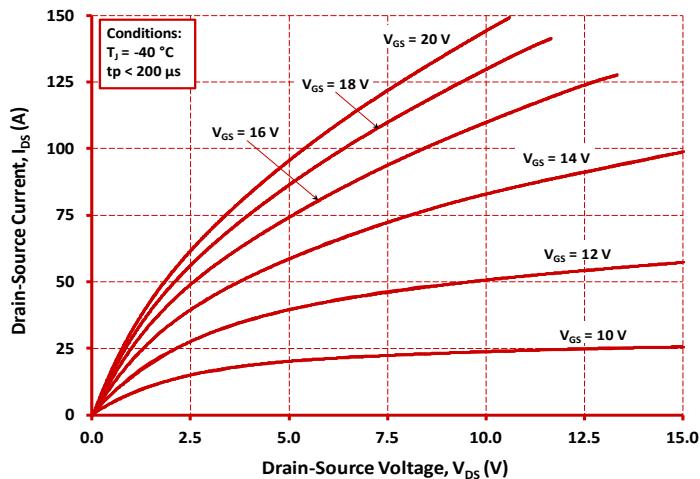


Figure 1. Output Characteristics $T_J = -40^\circ\text{C}$

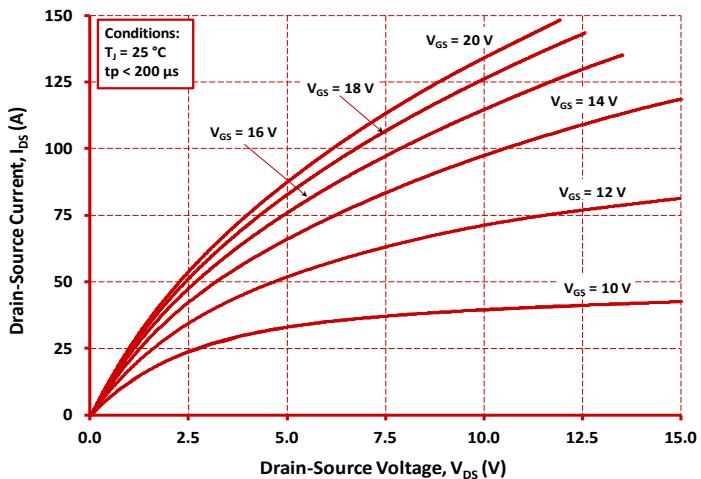


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

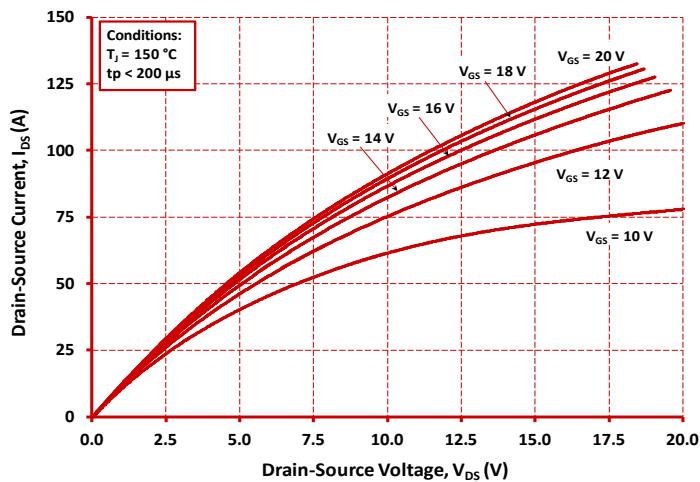


Figure 3. Output Characteristics $T_J = 150^\circ\text{C}$

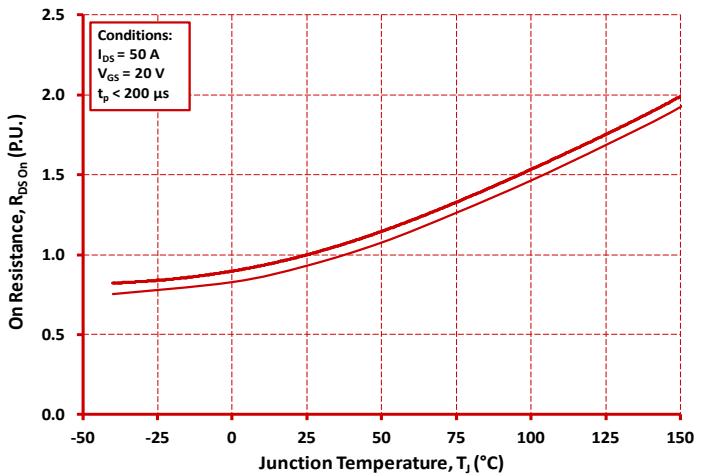


Figure 4. Normalized On-Resistance vs. Temperature

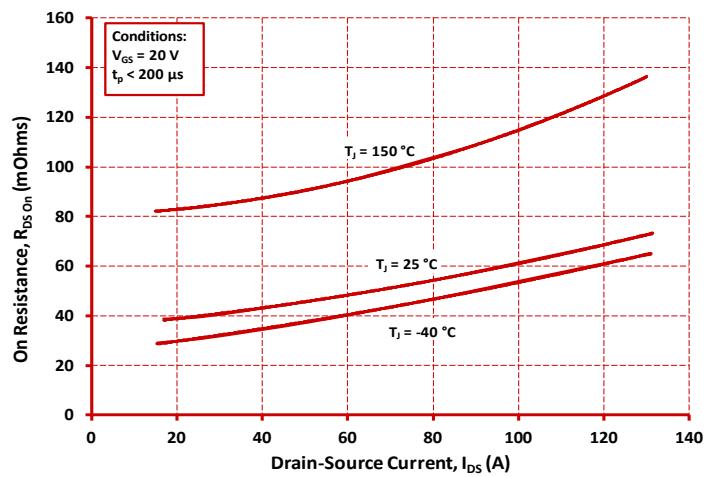


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

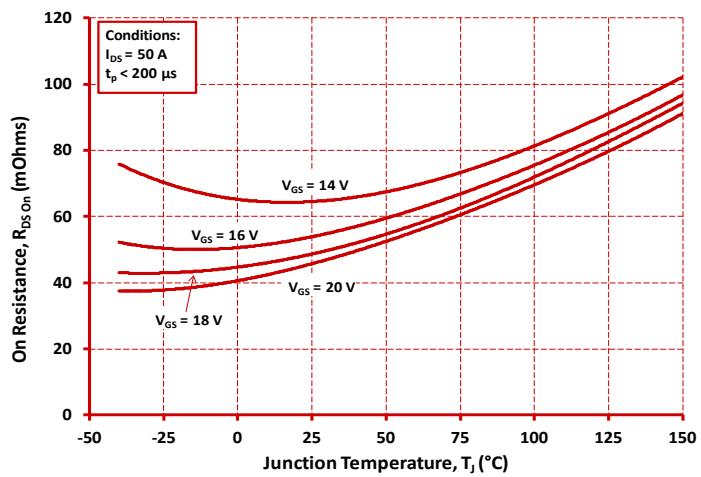


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage



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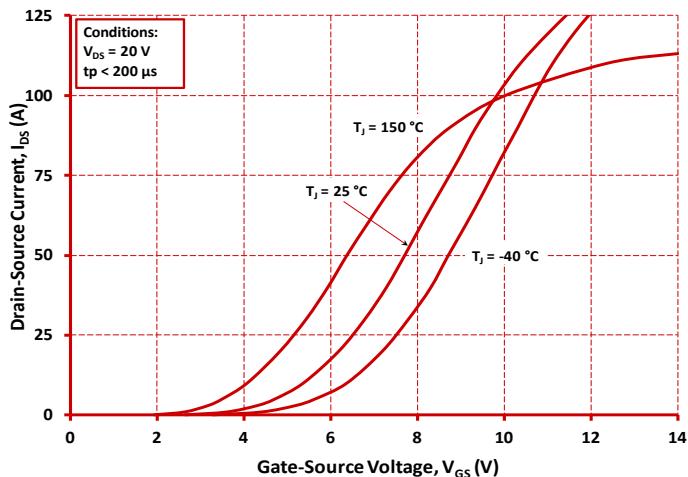


Figure 7. Transfer Characteristic For Various Junction Temperatures

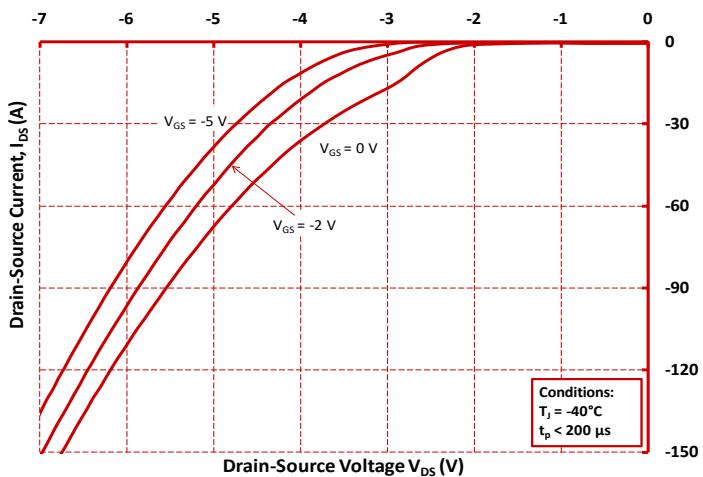


Figure 8. Body Diode Characteristic at -40°C

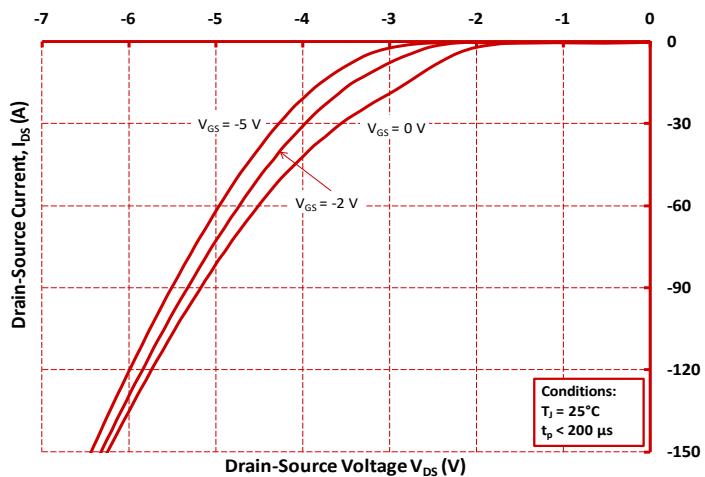


Figure 9. Body Diode Characteristic at 25°C

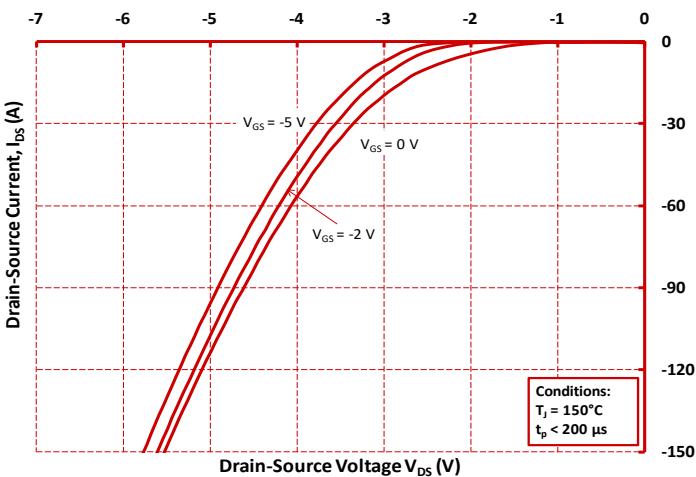


Figure 10. Body Diode Characteristic at 150°C

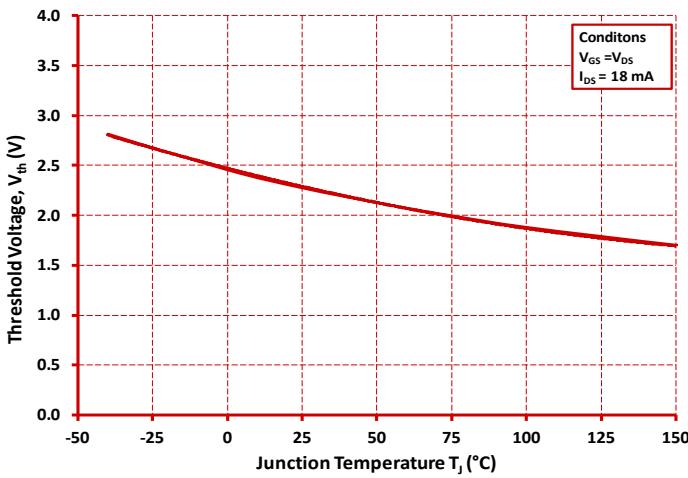


Figure 11. Threshold Voltage vs. Temperature

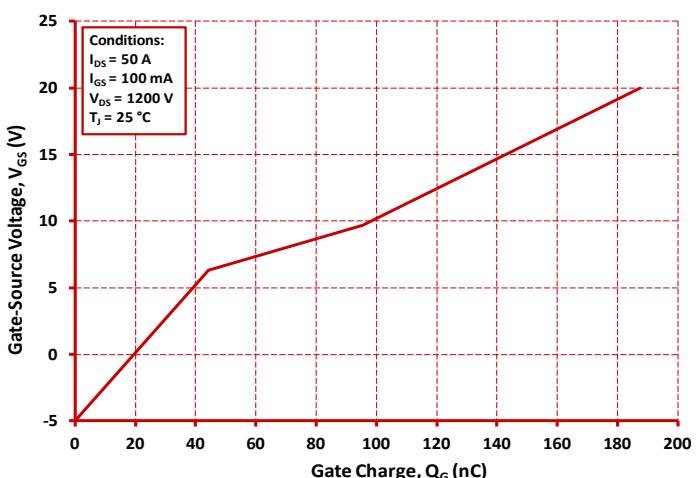


Figure 12. Gate Charge Characteristic



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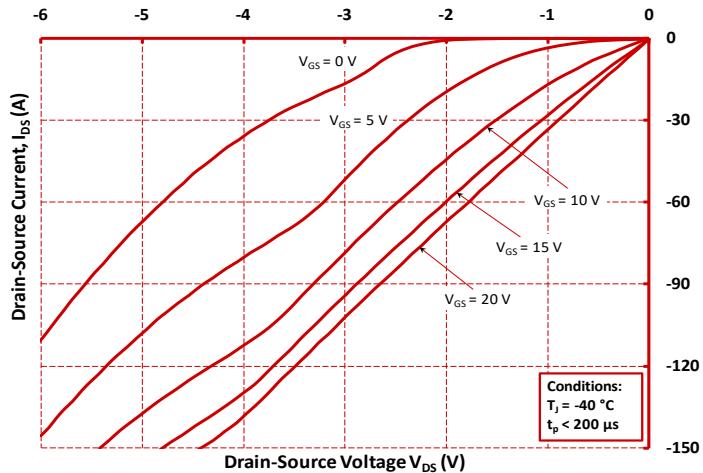


Figure 13. 3rd Quadrant Characteristic at -40°C

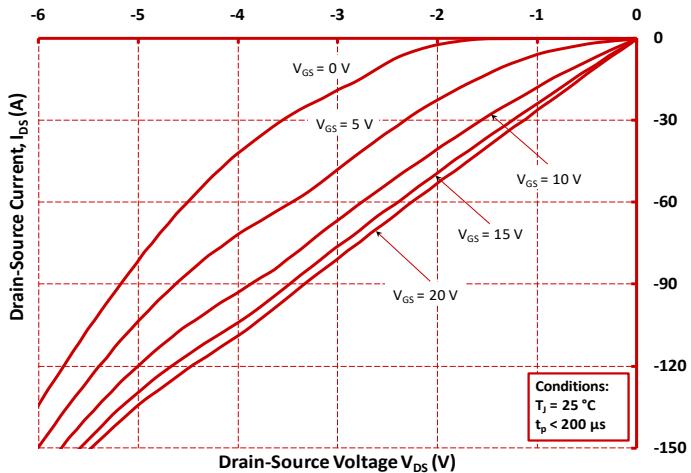


Figure 14. 3rd Quadrant Characteristic at 25°C

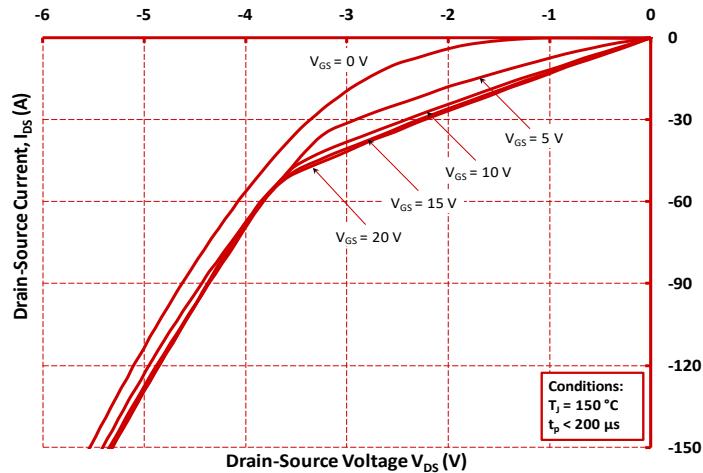


Figure 15. 3rd Quadrant Characteristic at 150°C

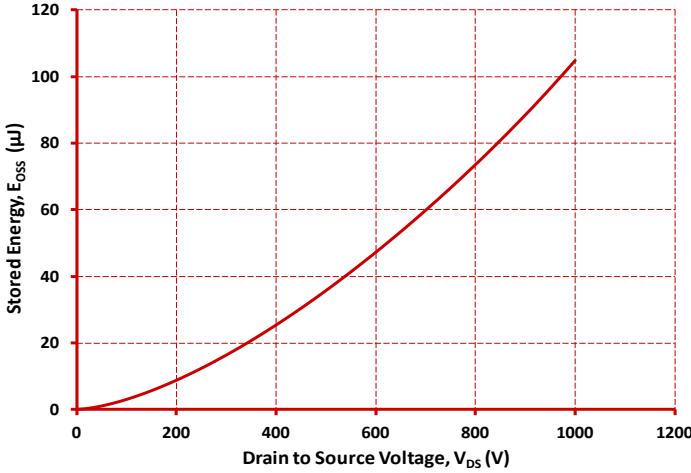


Figure 16. Output Capacitor Stored Energy

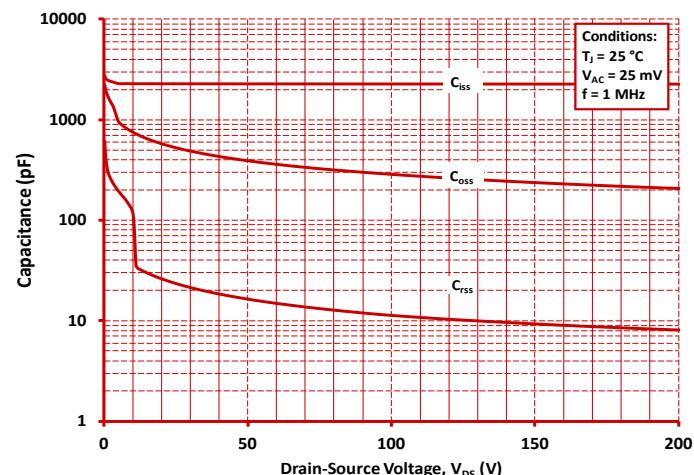


Figure 17. Capacitances vs. Drain-Source Voltage (0-200 V)

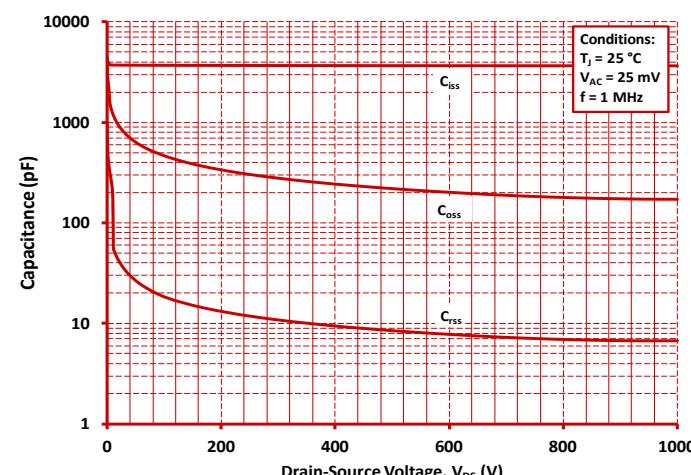


Figure 18. Capacitances vs. Drain-Source Voltage (0-1000 V)



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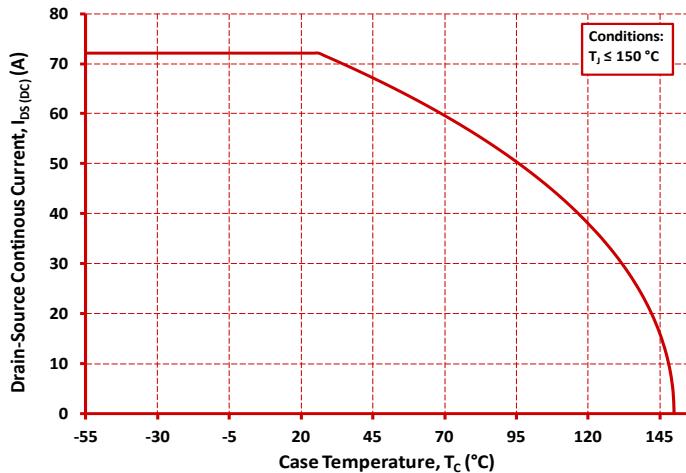


Figure 19. Continuous Drain Current Derating vs. Case Temperature

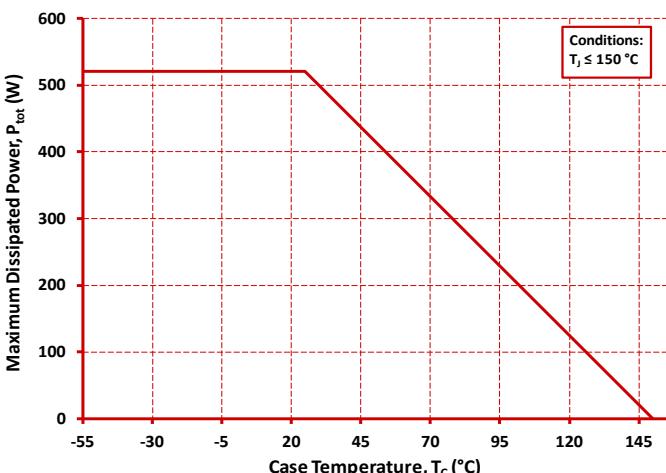


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

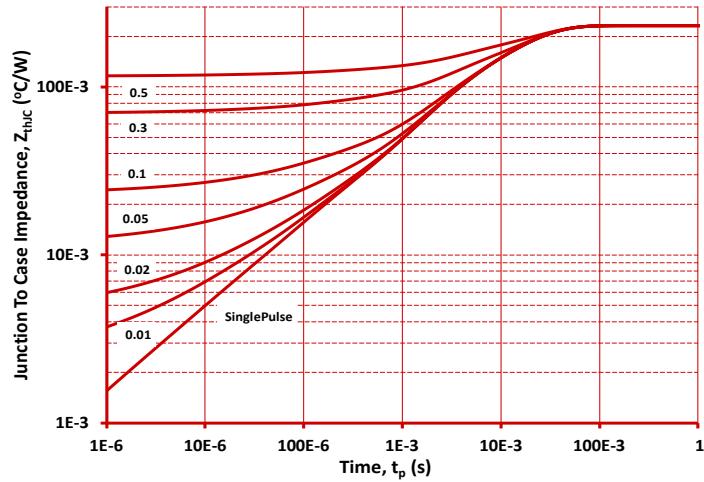


Figure 21. Transient Thermal Impedance (Junction - Case)

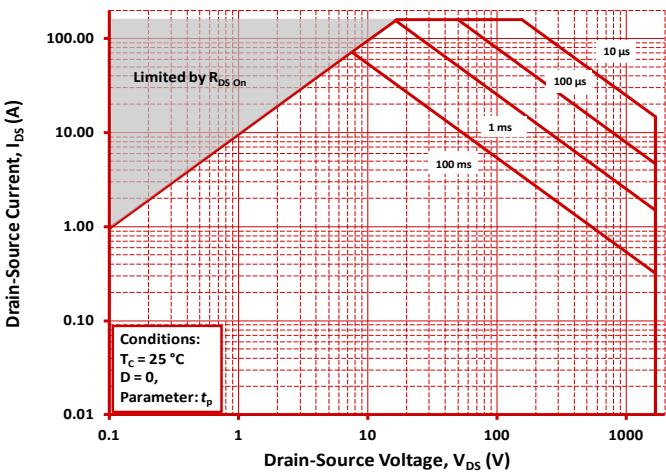


Figure 22. Safe Operating Area

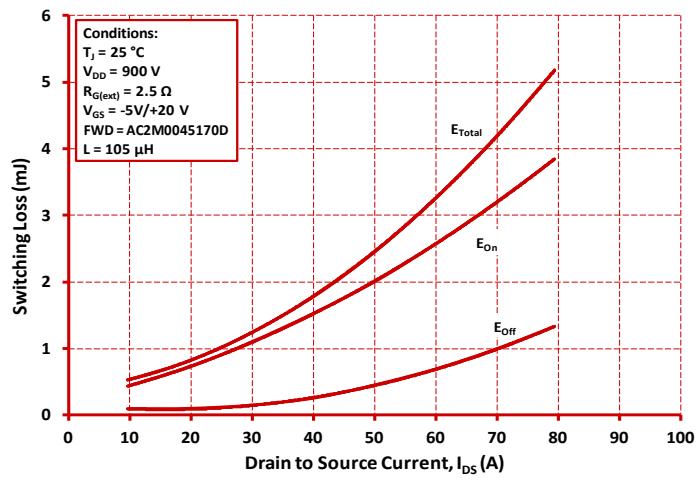


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 900V$)

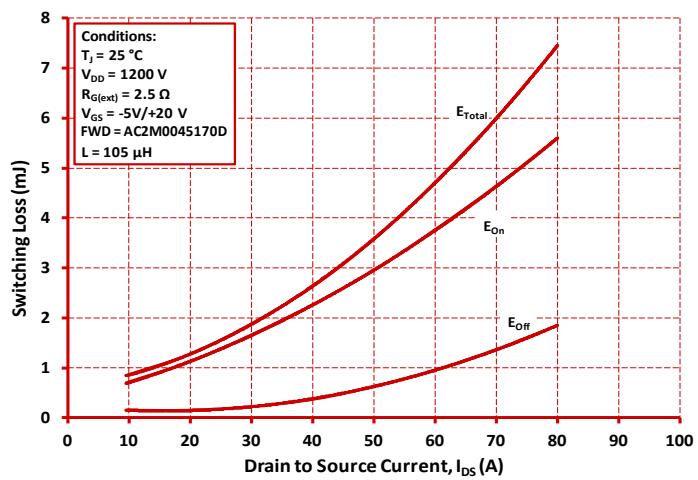


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 1200V$)



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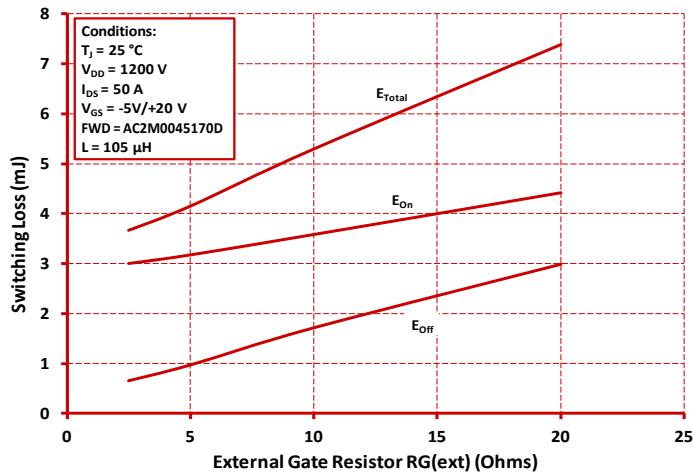


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

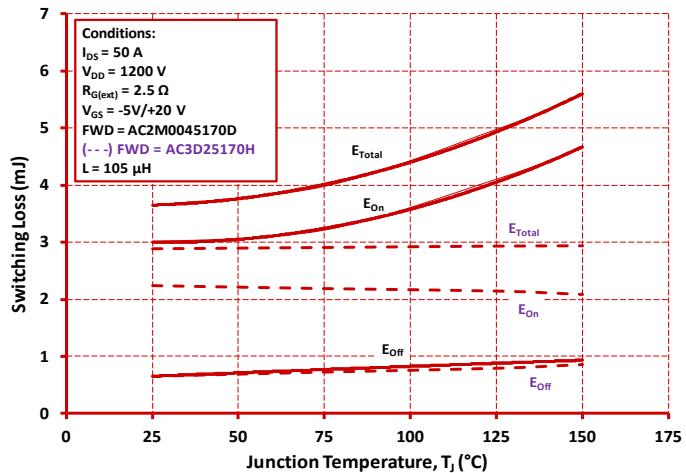


Figure 26. Clamped Inductive Switching Energy vs. Temperature

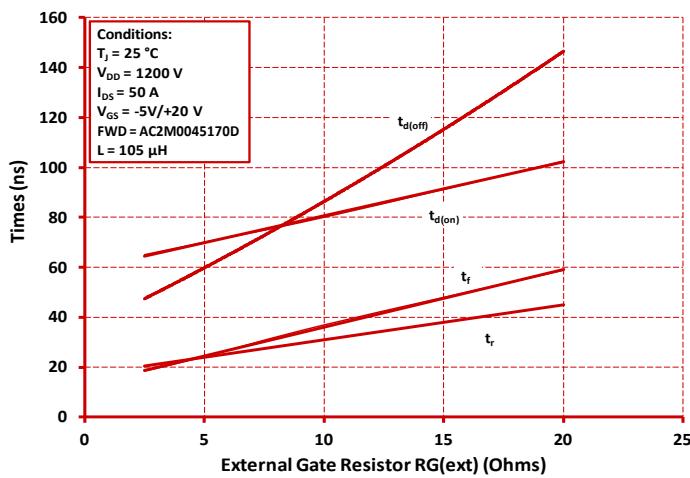


Figure 27. Switching Times vs. $R_{G(ext)}$

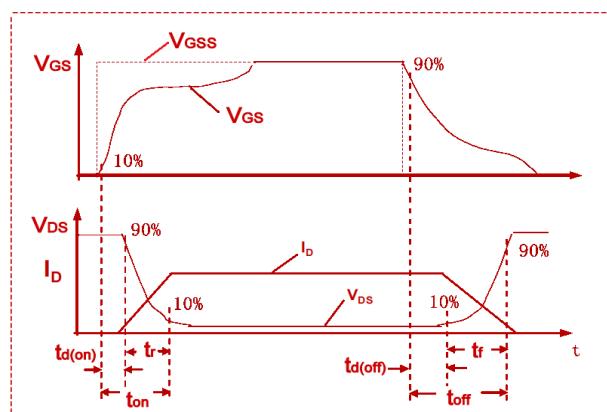


Figure 28. Switching Times Definition



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Test Circuit Schematic

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Fig.29 Switching Time Measurement Circuit

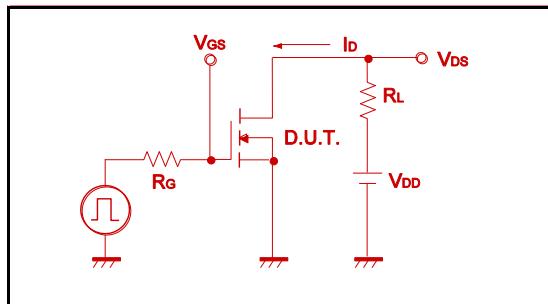


Fig.30 Switching Waveforms

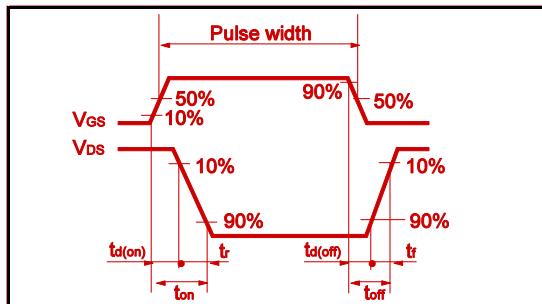


Fig.30-1 Gate Charge Measurement Circuit

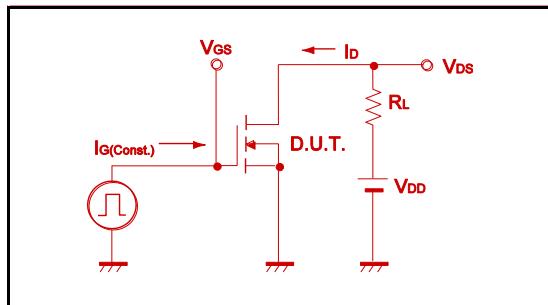


Fig.30-2 Gate Charge Waveform

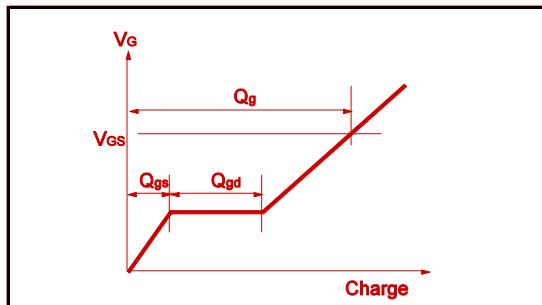


Fig.31-1 Switching Energy Measurement Circuit

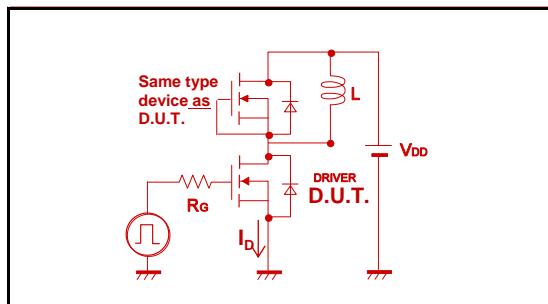


Fig.31-2 Switching Waveforms

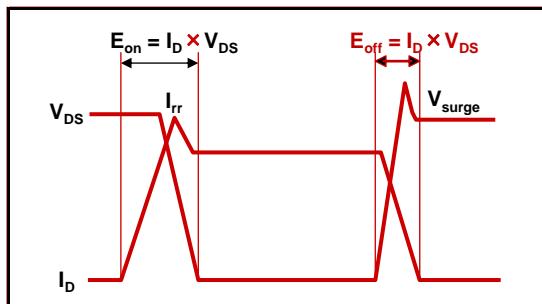
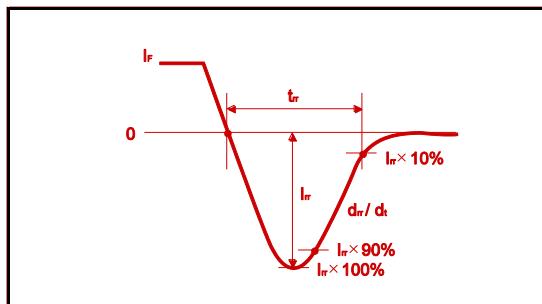
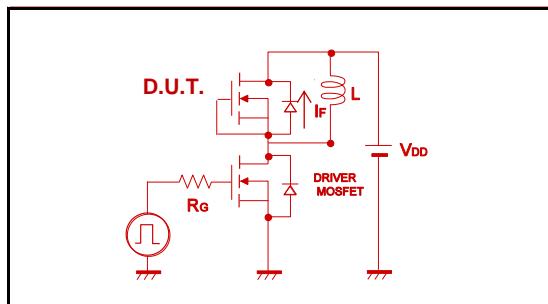
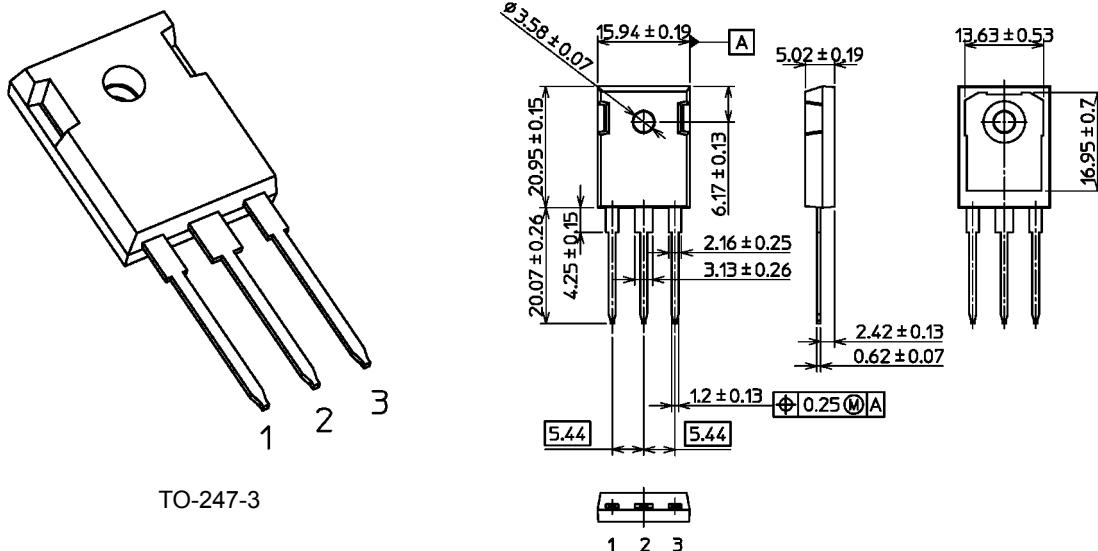


Fig.32-1 Reverse Recovery Time Measurement Circuit Fig.32-2 Reverse Recovery Waveform

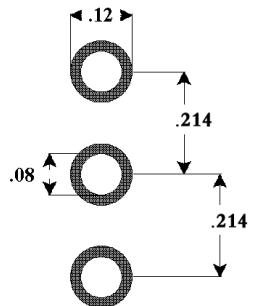


Package Dimensions

Unit: mm



Recommended Solder Pad Layout



TO-247-3